



Structural, Optical and Hardness Features of Copper Sulphate Crystallites for Optical Applications

HELEN MERINA ALBERT^{1,*}, T. RAJANI², D. NEELIMA PATNAIK³, M.V. SOMESWARARAO⁴,
P. VIMALA⁵, SANTOSH KUMAR NATHSHARMA⁶ and NELLORE MANOJ KUMAR⁷

¹Department of Physics, Sathyabama Institute of Science & Technology, Chennai-600119, India

²Department of Physics, VNR Vignana Jyothi Institute of Engineering and Technology, Hyderabad-500090, India

³Department of H&S (Physics), CMR College of Engineering & Technology, Hyderabad-501401, India

⁴Department of Engineering Physics, S.R.K.R. Engineering College, Bhimavaram-534204, India

⁵Department of Chemistry, Muthurangam Government Arts College, Vellore-632002, India

⁶Department of Chemistry, Stewart Science College, Cuttack-753001, India

⁷Department of Mathematics, Saveetha School of Engineering, Saveetha Institute of Medical and Technical Sciences (SIMATS), Thandalam, Chennai-602105, India

*Corresponding author: E-mail: drhelenphy@gmail.com

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In this investigation, copper sulphate crystals (CuSO_4) were produced by a slow evaporation process. Powder-X-ray diffraction (PXRD), Fourier transform infrared (FTIR) spectroscopy, UV-visible spectroscopy (UV-vis), second harmonic generation (SHG) and microhardness analyses were used to describe the structural aspects, optical parameters and hardness features of the derived crystals. The XRD measurements show that the CuSO_4 crystallized into a triclinic structure and the FTIR method was applied to assess the atomic vibrations in the CuSO_4 sample. The UV-Vis measurements demonstrated high transparency of CuSO_4 in the near-UV and visible spectra. The optical attributes, including refractive index, extinction coefficient, dielectric constants and optical and electrical conductivities of CuSO_4 were determined. The SHG ability of the powdered sample was explored by the Kurtz and Perry method and found to be 1.10 times that of the KDP. The mechanical characteristics of the CuSO_4 samples were demonstrated by the Vickers microhardness study. Excellent optical attributes, combined with suitable SHG and mechanical characteristics make the CuSO_4 crystals suitable for optoelectronic applications.

Keywords: CuSO_4 , X-ray diffraction, Second-harmonic generation, Microhardness.

INTRODUCTION

The non-linear optical materials have become increasingly important in science and technology in recent years. Non-linear optics involve non-linear interactions between the light and the medium. The crystals with non-linear optical properties are used for applications including, optical data storage, high-speed communications, frequency shifting, optoelectronics, photonics, *etc.* [1-4]. Pure inorganic crystals are highly advantageous for the impromptu and fast development of rapid optical communication networks. The advancement of existing photonic technologies, such as frequency conversion, optoelectronics, storing data, optical switching, UV filters, optical modulation and detection devices, is a continuous endeavour for the photonic

industry's developers. NLO device design is currently greatly aided by the wide range of inorganic compounds, *e.g.* potassium dihydrogen phosphate (KDP), potassium dideuterium phosphate (DKDP), ammonium dihydrogen phosphate (ADP), potassium niobate (KNbO_3), lithium niobate (LiNbO_3), *etc.* which are the building blocks of photonic devices [5,6]. Transparency, adequate quadratic susceptibility and the thermal stability to withstand powerful lasers without experiencing any negative effects are all necessary for crystals to be of such immense utility. When it comes to creating new NLO crystals, inorganic elements have long been considered the most important component.

The ability of an inorganic class of materials to organize themselves into single crystals that offer wide optical transparency, frequency conversion, better optical response and diele-

ctric features has drawn the attention of researchers [7,8]. The inorganic materials are more advantageous than the organic counterparts in design flexibility and strong mechanical and thermal stability in high-power laser applications.

Researchers must thoroughly examine the intriguing inorganic copper sulphate (CuSO_4) crystal. CuSO_4 finds important uses in the printing and building sectors, moreover, CuSO_4 is used in the artwork and fireworks engineering as a colouring agent. The aqueous solution of CuSO_4 is widely used as a resistive element in the electronic liquid resistors [9,10]. Initially, Manomenova *et al.* [11] described the crystal formation of $\text{CuSO}_4 \cdot 5\text{H}_2\text{O}$, suitable for broadband optical filters. However, Justel *et al.* [12] reported the crystallization of $\text{CuSO}_4 \cdot 5\text{H}_2\text{O}$ from a aqueous solution using NaCl. Inspired by the earlier work on CuSO_4 crystals, the high-quality CuSO_4 crystals were developed by a gradual evaporation procedure in the present study for the optical and nonlinear optical applications.

EXPERIMENTAL

The starting reagent copper sulphate pentahydrate (AR grade) was purchased from Sd-fine Chemicals, India and purified by repeated recrystallization processes to ensure their purity. Recrystallized chemicals were used for the synthesis process. A gradual evaporation process was applied for the formation of CuSO_4 crystals. Initially, a saturated solution of $\text{CuSO}_4 \cdot 5\text{H}_2\text{O}$ was prepared using 25 mL of deionized water at 32 °C. The saturated solution was stirred well for around 4 h by a magnetic stirrer and then filtered using micro-filter paper to remove any remaining contaminants. The solution was subsequently maintained in a 100 mL beaker equipped with a porous cover to promote the gradual evaporation of the solvent. A high-quality CuSO_4 crystals with optimum size were obtained in 20 days (Fig. 1).

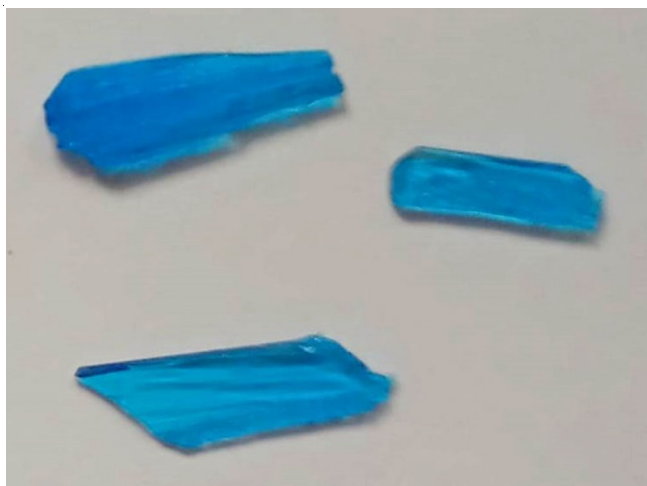


Fig. 1. Photograph of as-produced CuSO_4 crystals

Characterization: The detection method includes the structural and physico-chemical characteristic analysis. The Reich-Seifert 3003-TT diffractometer was employed for the powder XRD investigations to investigate the crystal form and lattice constants for the CuSO_4 samples. An FT/IR-6600 type-A

spectrometer was used to get the FTIR spectrum of the test sample. The optical properties were studied in the UV-visible spectral area using a Jasco International Co., Ltd. (V670 spectrophotometer), Japan. The Kurtz and Perry method was followed to evaluate the second harmonic generation of CuSO_4 powdery samples. A temperature-controlled, angle-tuned and extremely effective generator was used for the Kurtz and Perry analysis. The Vickers microhardness machine and a diamond pyramidal indenter were used to measure the hardness nature of the prepared crystals.

RESULTS AND DISCUSSION

P-XRD studies: The most popular non-destructive testing method for identifying crystalline materials is X-ray diffraction (XRD). Tiny CuSO_4 samples were chosen for the experimental analysis. The peak intensities were found by scanning the CuSO_4 sample in 2θ orientations between 0° and 110°. Fig. 2 shows the XRD peaks of CuSO_4 crystal. The diffractogram shows the peaks with 2θ values of 18.964°, 22.48°, 27.68°, 31.84°, 37.72°, 42.50°, 56.97°, 67.75° and 86.62°. A significant peak is found around 18.964°. The crystallographic planes associated with the indexed peaks are (100), (110), (111), (200), (210), (211), (311), (401) and (422). Considering the XRD findings, the CuSO_4 crystallized in a triclinic configuration with the $P1$ group. The lattice parameters were obtained to be $a = 5.97 \text{ \AA}$, $b = 6.11 \text{ \AA}$, $c = 10.70 \text{ \AA}$, $\alpha = 77.27^\circ$, $\beta = 82.32^\circ$, $\gamma = 72.56^\circ$. The values agree rather well with the previously reported data of CuSO_4 crystal [13].

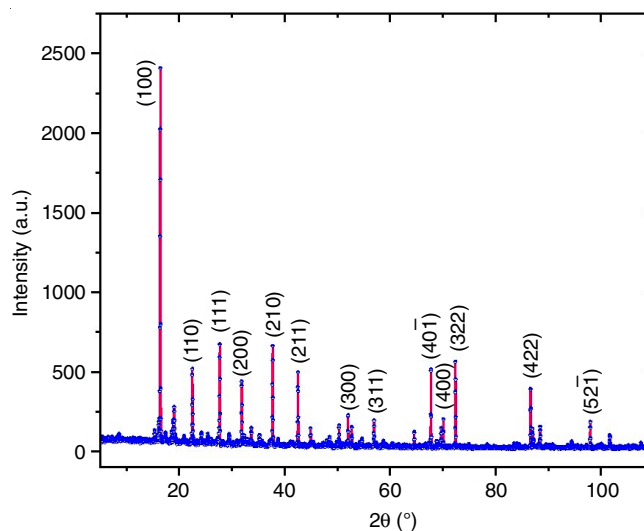


Fig. 2. The XRD spectrum for CuSO_4 crystal

FTIR studies: Fig. 3 displays the recorded FTIR spectrum of CuSO_4 between 4000 and 400 cm^{-1} . The spectrum shows a broad absorbance band in the higher wavenumber region between 3065 and 3575 cm^{-1} . This broad absorbance is because of the stretching vibration of the water molecules. The weak bands found between 2500 and 2000 cm^{-1} are due to the OH group in the crystal. The strong band at 1623 cm^{-1} is due to the bending mode of the OH group, whereas the strong bands at 1149 and 1091 cm^{-1} are due to the asymmetric and symmetric

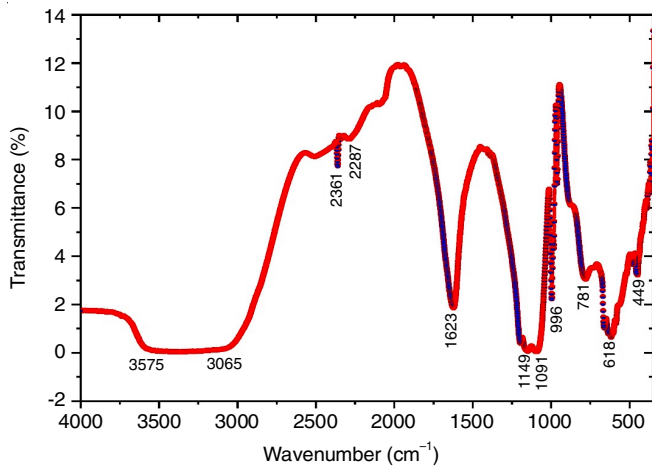


Fig. 3. FT-IR spectrum of CuSO₄ crystal

vibrations of the S=O group. The bands at 996 and 618 cm⁻¹ are due to the SO₄²⁻ non-degenerate and degenerate modes. The band at 781 cm⁻¹ is because of the Cu-O-H coordination, while the peak at 449 cm⁻¹ is due to the SO₄²⁻ bending mode.

UV-Vis spectral studies: The optical property was investigated in the 300-650 nm wavelength range and the spectrum (Fig. 4) shows that the transmittance of CuSO₄ initially increases from 300 nm and attains a maximum percentage at 325 nm. From 325 nm to 575 nm, the sample shows a constant maximum transmittance and then shows a slight decrease in the transmittance. The CuSO₄ sample is highly transparent in the wavelength range between 325 nm and 575 nm, making it suitable for optical applications such as optical bandpass filters in this spectral region. The UV data was interpreted to investigate the optical bandgap of CuSO₄. The Tauc formula was applied to determine the absorption coefficient (α) of CuSO₄ sample [14]:

$$\alpha h\nu = A(h\nu - E_g)^n$$

where E_g denotes the bandgap; A is the constant and n refers to an integer. For a permissible direct transition, n should be 2. The curve generated between hν and (αhν)² is illustrated in

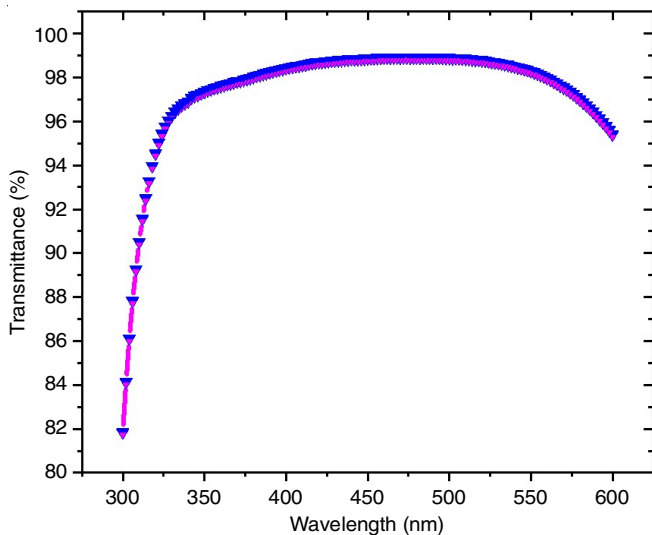


Fig. 4. Optical transmittance spectrum of CuSO₄ crystals

Fig. 5 and based on the plot, the bandgap of CuSO₄ is found to be 3.9 eV.

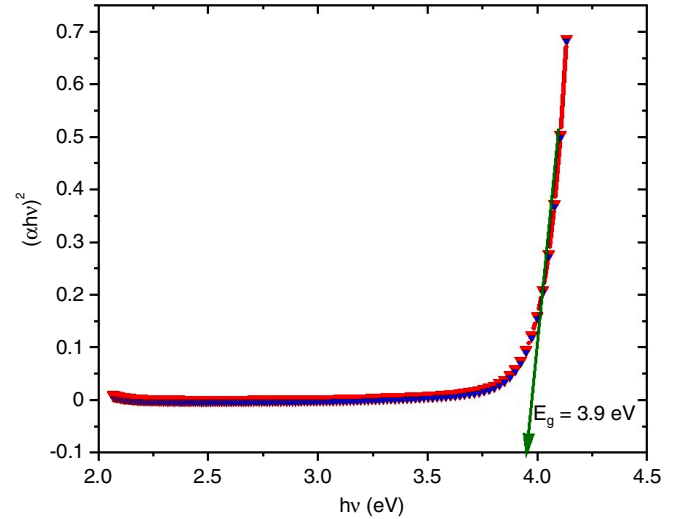


Fig. 5. Tauc plot of prepared CuSO₄ crystal

When incident light interacts with a material, it can either be refracted or absorbed; the degree of this relies on the conductivity, refractive index and extinction coefficient of the material [15]. The refractive index (n) was obtained through the following expression:

$$n = \frac{1}{T_s} + \sqrt{\frac{1}{T_s} - 1}$$

where T_s denotes the (%) transmittance.

The wavelength-related variation in the refractive index is displayed in Fig. 6. The curve demonstrates that the refractive index decreases significantly from the 300 to 325 nm range. The refractive index exhibits a slight decrease thereafter, attaining a minimum value of 1.112 within the 350-550 nm wavelength range. With the further wavelength increase, the refractive index marginally increases.

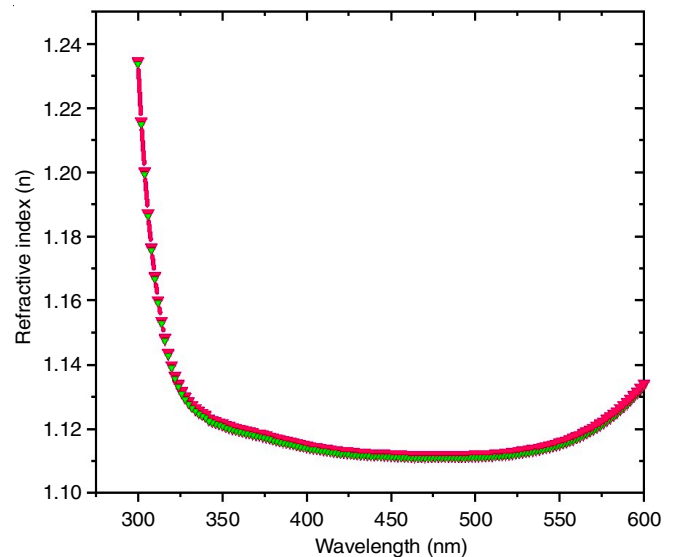


Fig. 6. Plot of variation in the refractive index against wavelength

The potential of an element to either reflect or absorb light at a designated wavelength is represented by its extinction coefficient (k), which can be represented as [16]:

$$k = \frac{\alpha\lambda}{4\pi}$$

Fig. 7 illustrates the correlation between k and λ of light. The curve shows that the k value is maximum at 300 nm. With the increase in wavelength, the k value decreases considerably, attaining a low value at 325 nm. The k value is the minimum in the 325–550 nm wavelength range. The optical conductance of CuSO_4 was evaluated using the below formula [17]:

$$\sigma_{\text{opt}} = \frac{n\alpha c}{4\pi}$$

where c is the velocity of light.

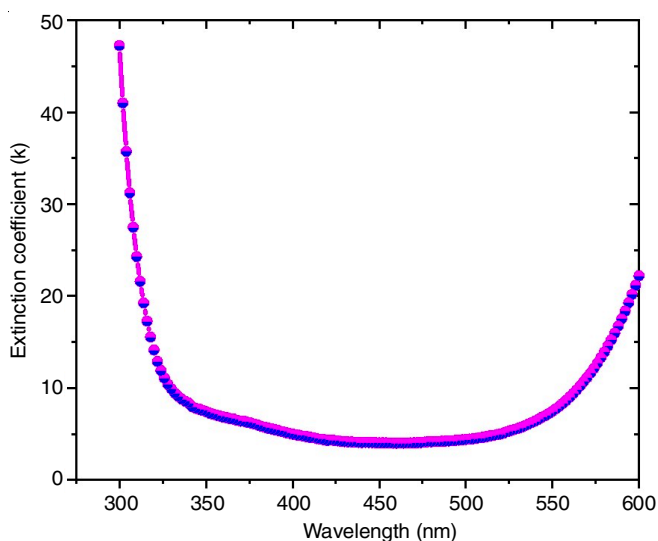


Fig. 7. Plot of extinction coefficient variations with wavelength

Fig. 8 illustrates the dependency of the optical conductance of CuSO_4 with the light energy. The optical conductance slightly decreases in the 2.0–2.5 eV energy range and attains a minimal value. After that, the optical conductance slightly

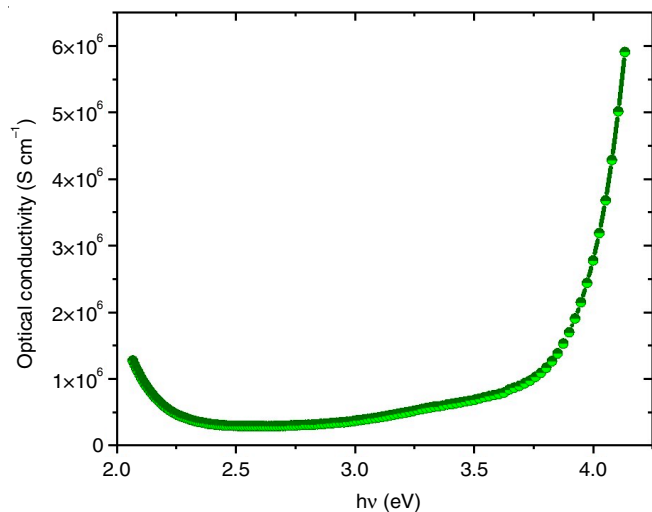


Fig. 8. Plot of variations in optical conductivity against photon energy

increases in the 2.5–3.55 eV energy range, then it increases sharply to reach its maximum at 4.10 eV. The excellent optical conductivity of the prepared CuSO_4 crystal validates the remarkable photoresponse of the material. This characteristic improves the suitability of the material for applications involving information processing.

The relationship between the electrical conductivity (σ_{ele}), optical conductivity (σ_{opt}) and absorption coefficient (α) is given by the following expression [18]:

$$\sigma_{\text{ele}} = \frac{2\lambda\sigma_{\text{opt}}}{\alpha}$$

Fig. 9 shows the electrical conductivity variation about the photon energy. The CuSO_4 crystal is found to have higher electrical conductivity at the lower energy photons. With the increase in photon energy, the electrical conductivity decreases linearly and attains a minimum value at higher energy.

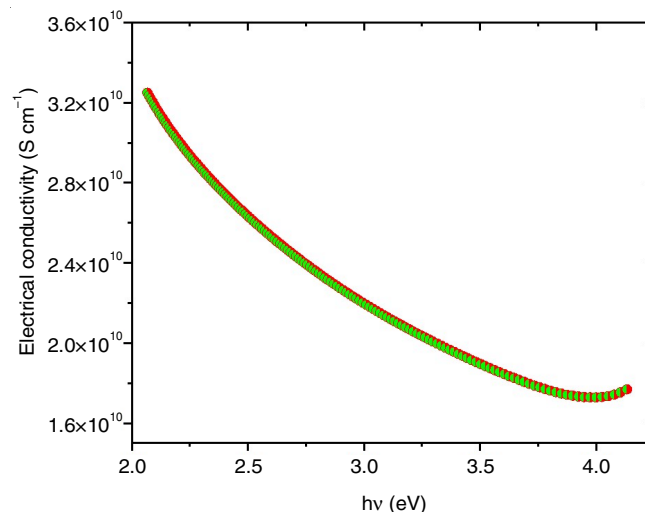


Fig. 9. Plot of variations in electrical conductivity against photon energy

The complex dielectric constant (ϵ^*) is described by the relation [19]:

$$\epsilon^* = \epsilon_1 + i\epsilon_2$$

The dielectric real (ϵ_1) and imaginary (ϵ_2) portions were determined from the relations:

$$\epsilon_1 = n^2 - k^2 \text{ and } \epsilon_2 = 2nk$$

Fig. 10 shows the variation of dielectric constant portions ϵ_1 and ϵ_2 related to the wavelength. Observations revealed that the real portion (ϵ_1) behaves like the transmittance spectra, increasing from 300 to 325 nm and then reaching a maximum saturation in the higher wavelength region. On the other hand, the imaginary portion (ϵ_2) exhibits a steep decline from 300 to 325 nm and then reaches the minimum saturation in the higher wavelength region.

Second harmonic generation test: The SHG value of CuSO_4 sample was evaluated with the Kurtz & Perry method [20]. The SHG experiment used a “Q-switched Nd: YAG laser” functioning at 1064 nm with a 6 ns pulse width. The greenish light of CuSO_4 powder (532 nm) emission verified the production of the second harmonic radiation. The powdered KDP was

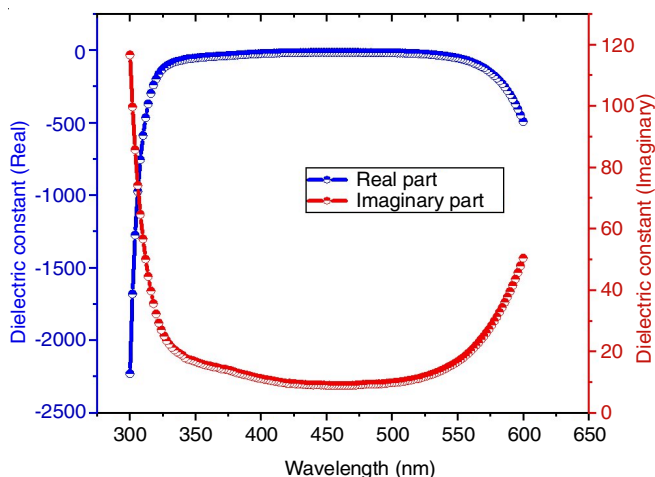


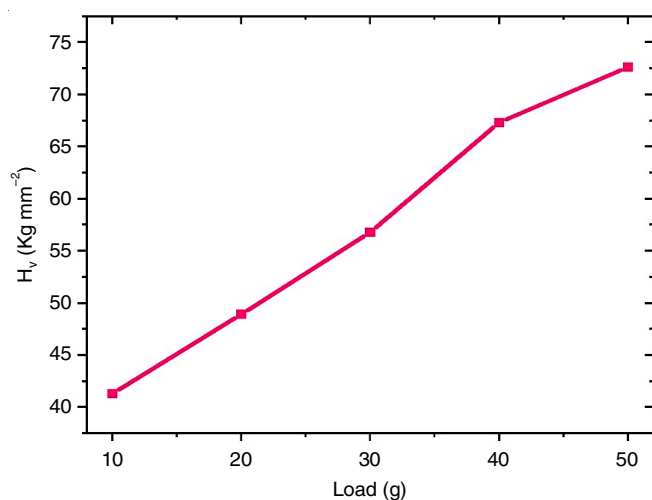
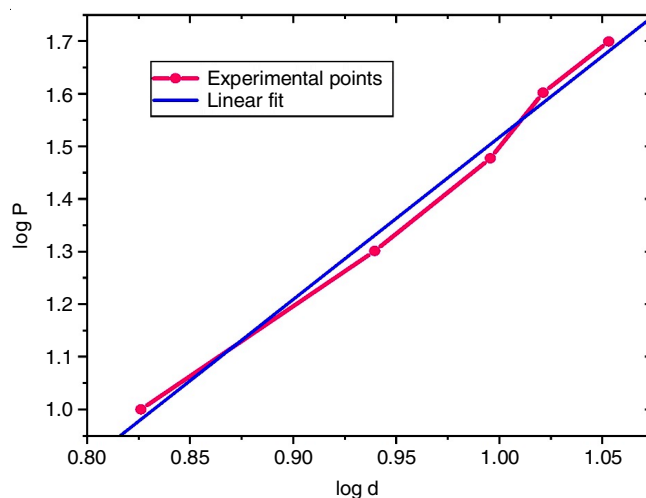
Fig. 10. Variation of the dielectric constants with wavelength

served as the reference material. The prepared CuSO_4 was found to have a second harmonic ability 1.10 times that of the KDP.

Microhardness analysis: Hardness measurement is a helpful non-destructive testing technique to ascertain a strength or ability of the material to withstand deformations [21]. Several features like lattice energy, interatomic spacing, temperature and heat generation affect a material's hardness. The crystalline samples were carefully polished during the experimental procedure to prevent surface imperfections. Loads of varying scales (10, 20, 30, 40 and 50 g) were applied to CuSO_4 crystals on the microhardness tester platform for a predetermined time (10 s). Due to the creation of microcracks at greater stresses, the highest applied load was limited to 50 g. The microhardness of CuSO_4 was evaluated using the following equation [22]:

$$H_v = \frac{1.8544P}{d^2} \text{ Kg/mm}^2$$

where, P represents the applied load and d is the typical indentations. The microhardness number (H_v) is shown against the applied load in Fig. 11 and it is observed that the H_v starts at 5 kg and increases with increasing load. The graph of Log P vs. log d is displayed in Fig. 12. The plot indicates a linear increase in log d with log P. The least-square fit approach was applied to

Fig. 11. Variation in the microhardness value (H_v) under applied load (P)Fig. 12. Variation of log P with log d for crystal CuSO_4 crystal

determine the work hardening coefficient (n). According to the Onitsch's proposal, a material is classified as soft if its n value is greater than 1.6 and as hard if it is between 1.0 and 1.6 [23]. The results reveal that the n value is 3.02, representing that CuSO_4 is a soft material.

Conclusion

The copper sulphate CuSO_4 crystals were produced using the gradual evaporation procedure and characterized by powder-XRD, FTIR, UV-Vis, SHG and microhardness analyses. The XRD measurements show that the CuSO_4 crystallized into the triclinic form. The distinct diffraction peaks in the XRD spectrum define the excellent crystalline state of the samples. The optical measurements demonstrated high transmittance of the CuSO_4 in the UV-visible spectrum. The bandgap of CuSO_4 is found to be 3.9 eV and also have a second harmonic ability 1.10 times that of the KDP. Microhardness analysis indicates that the hardness number H_v increases with the increasing load. The prepared CuSO_4 crystals exhibit remarkable optical transparency and optical properties, along with the appropriate second harmonic generation and microhardness characteristics, rendering them suitable for the optoelectronic applications.

CONFLICT OF INTEREST

The authors declare that there is no conflict of interests regarding the publication of this article.

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